## Notic of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination CHALLA ET AL. | Examiner | Art Unit | Emmanuel Bayard | 2631 | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,790,589	08-1998	Hutchison et al.	375/149
	В	US-5,764,687	06-1998	Easton, Kenneth D.	375/147
	O	US-6,567,462	05-2003	Brunner et al.	375/148
	D	US-6,424,816	07-2002	Stephens, Scott A.	455/2.01
	Е	US-5,781,543	07-1998	Ault et al.	370/342
	F	US-2002/0024992	02-2002	Ogawa et al.	375/148
	G	US-6,621,855	09-2003	Van Stralen et al.	375/142
	I	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				_	
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	v						
	w						
	x						

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